



Design of an Experimental Platform for In-Situ Single Photon Source Detection

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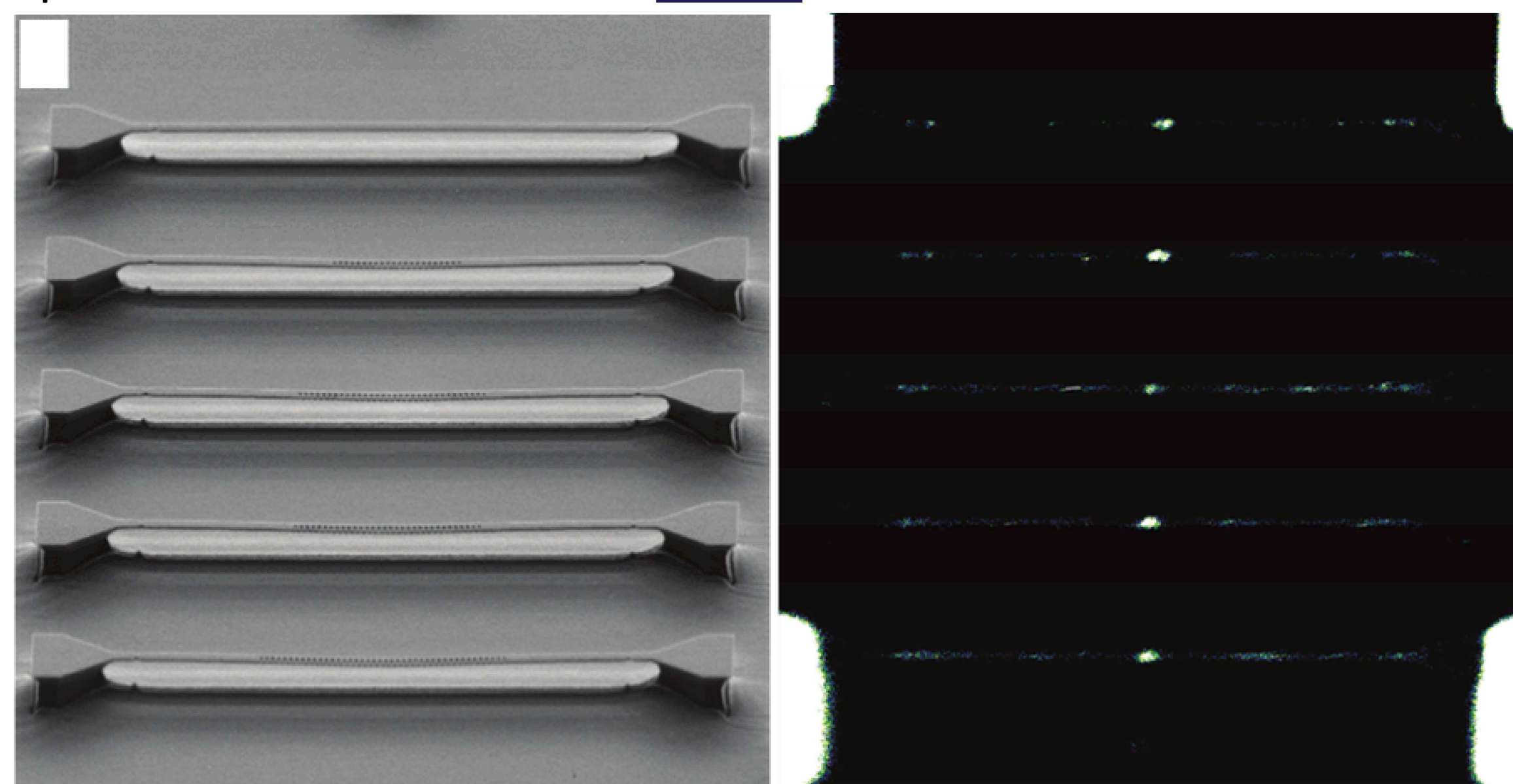
Motivation

Why Solid-state Single Photon Sources?

- Applications range from quantum enhanced sensing to quantum information transfer and quantum computing
- To make use of the quantum nature of light, need on demand high purity single light quanta, i.e. single photons
- Color centers are ideal candidates for high density and long coherence time quantum platforms

Key CINT capability:

High-resolution implantation of defects in virtually any material and donors in materials such as diamond, SiC, hBN, etc... enabling the placement of color centers where we need it.

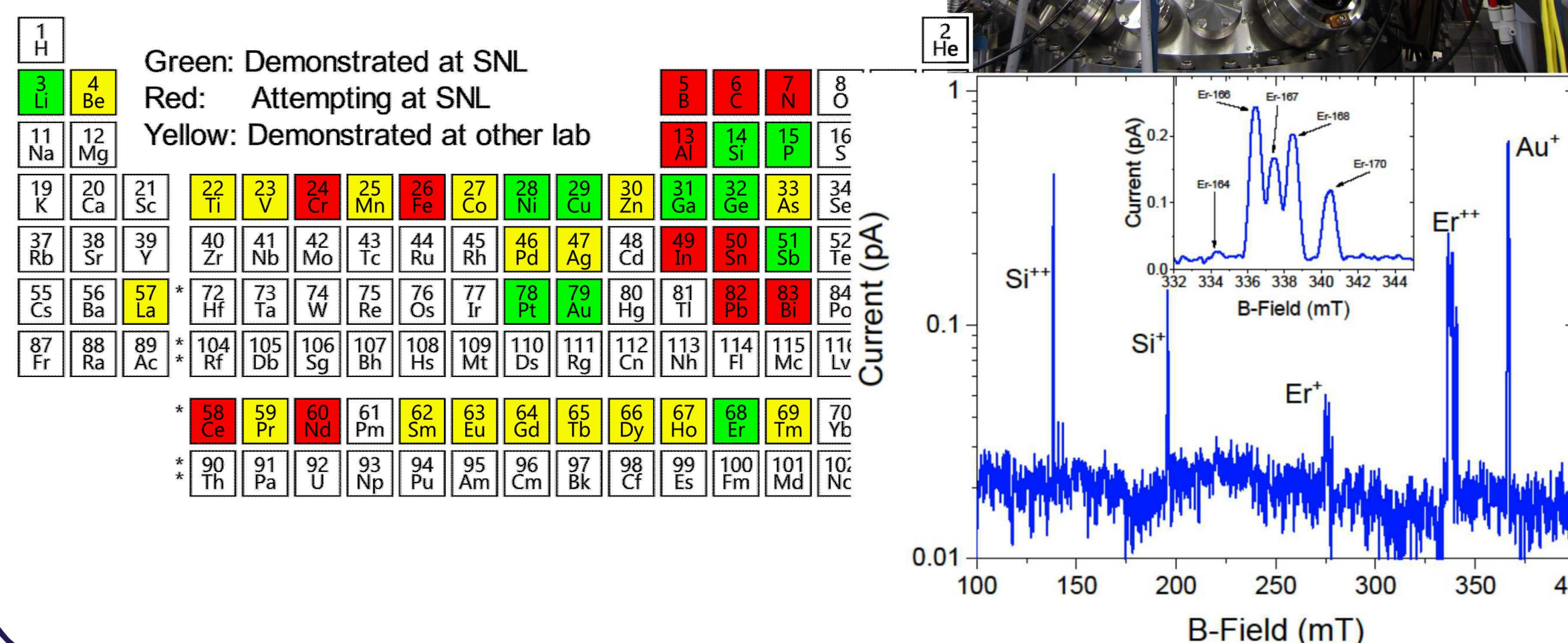
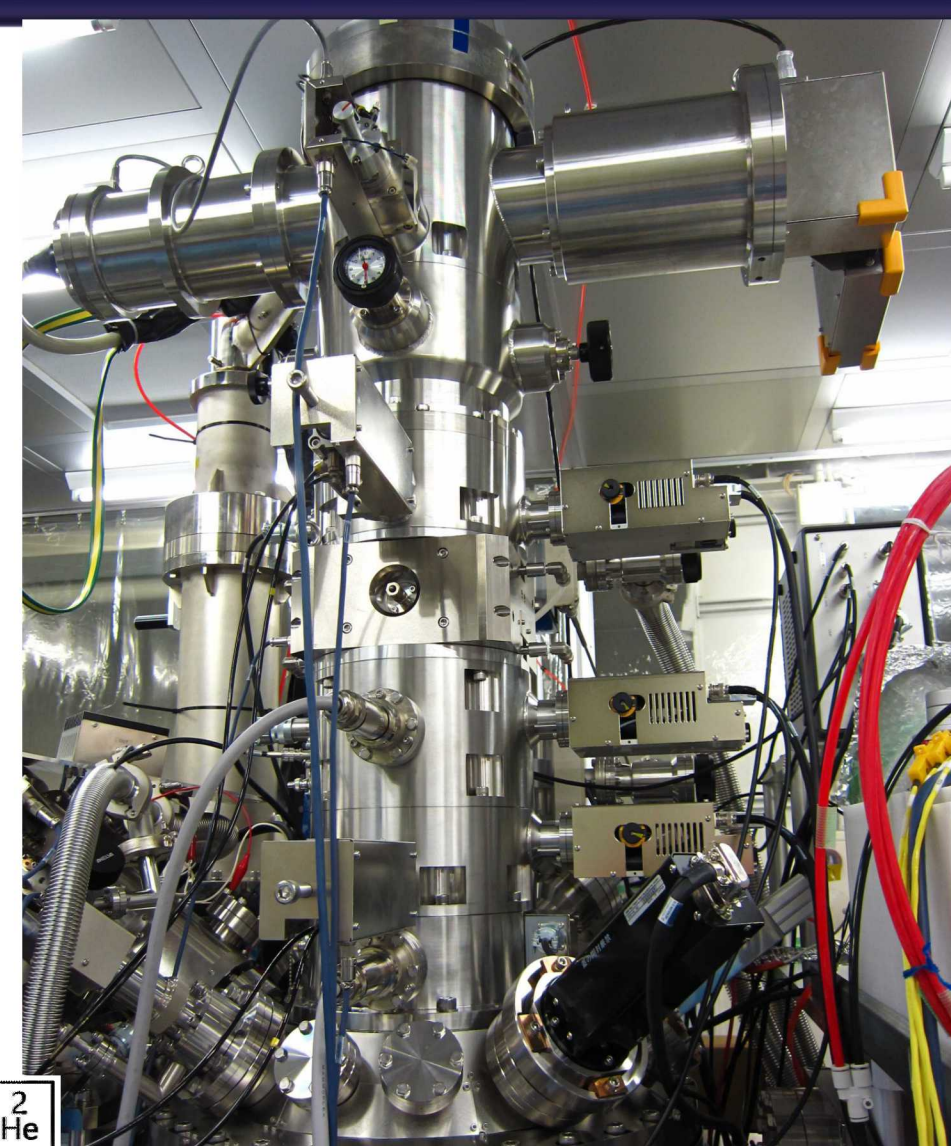


A. Sipahigil et al., Science 354 (6314) 847 (2016)

Nanoscale Ion Implantation

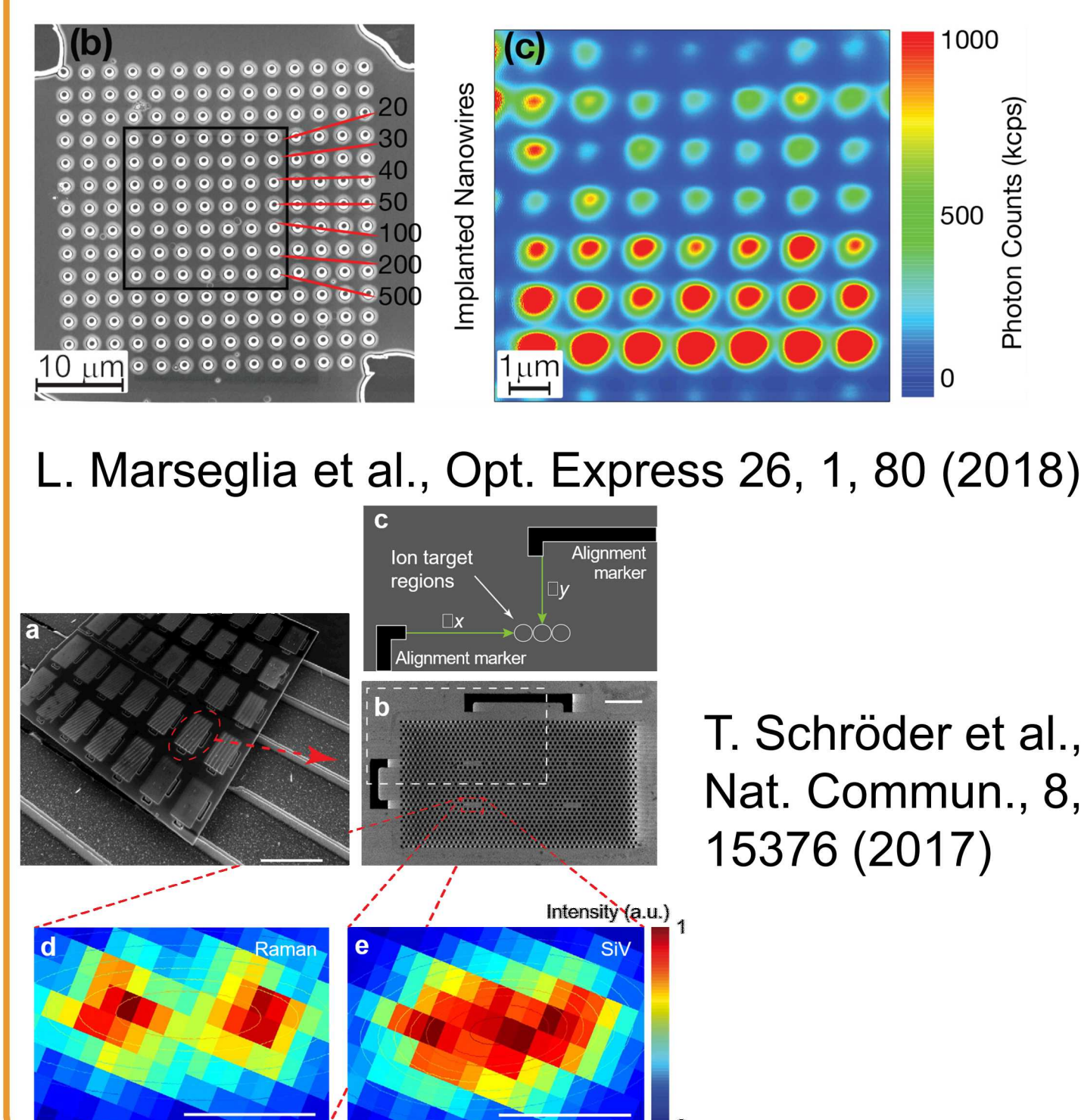
nanolmplanter

- Focused ion beam system (FIB) nm spot sizes on target
- ExB (Wien) Filter Ion and isotope selectivity
- Fast blanking and chopping Single ion implantation
- In-situ electrical probes Single ion detection

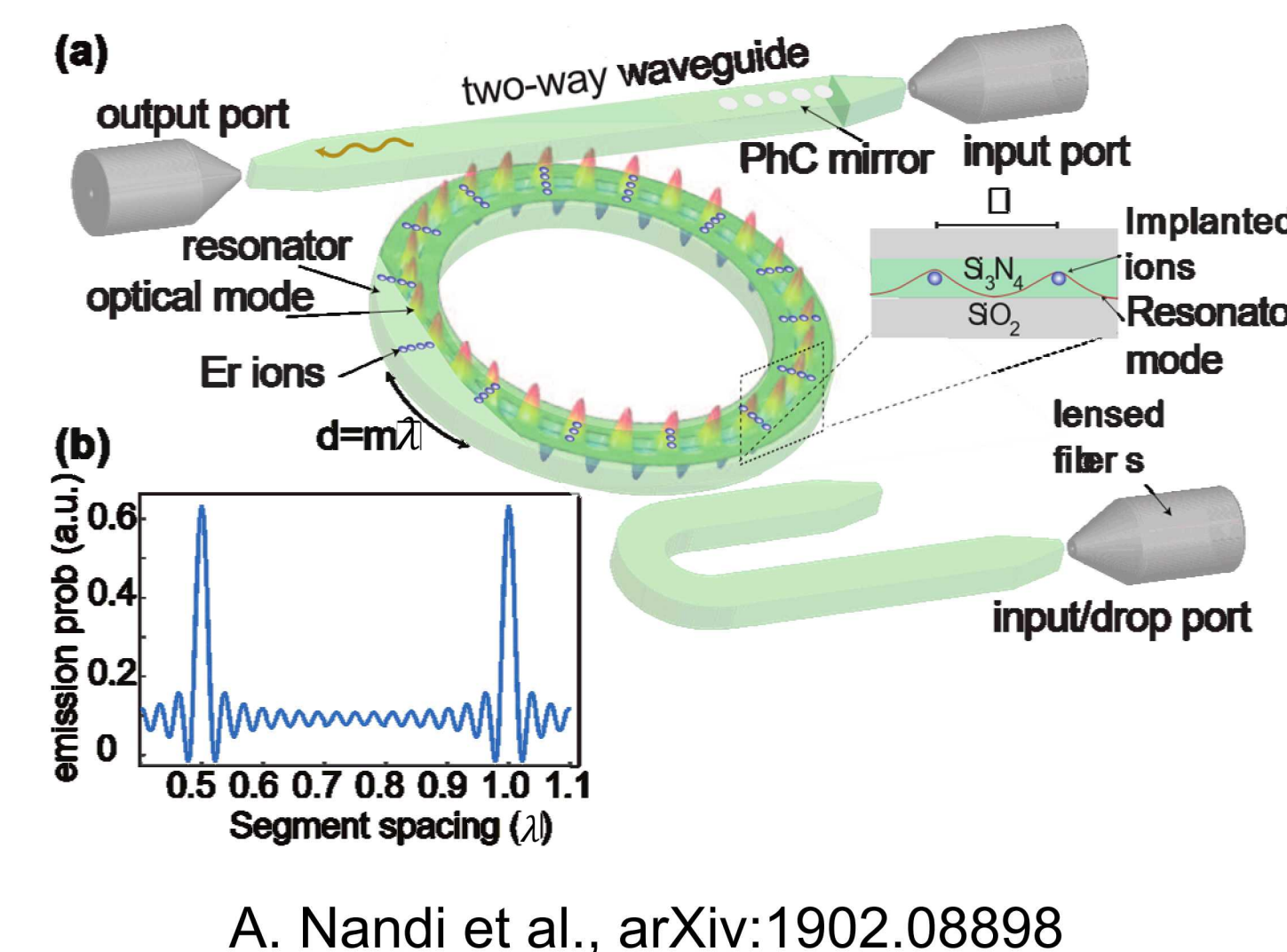


Current Collaborations & Roadmap

Quantum Optics with SiV, GeV



Collective resonances in Fiber



NV in Diamond

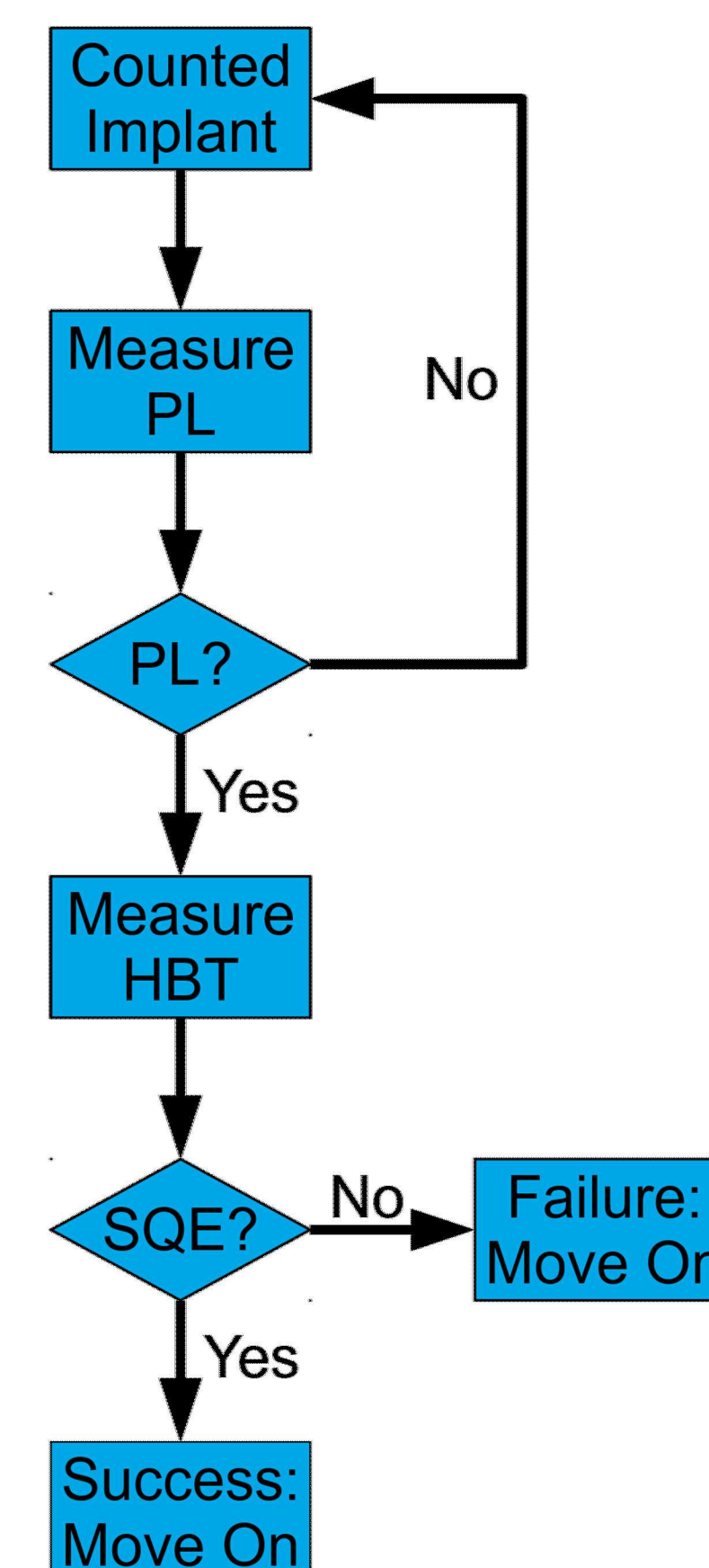
- N source development
 - Ionic Liquid Ion Source (MIT)
 - Implant Liquid Metal Source with N (SNL)
- NV-NMR under development for quantum material characterization (see Ziabari et al.)
- Add in-situ anneal to nanolmplanter
 - Heated implants (MIT)
 - Laser annealing (U Torino, Italy)

High-resolution ion implantation is necessary to enable these experiments, BUT how do we produce a deterministic SPS?

Low Optical Yield – How to Ensure SPS Generation?

Creating optically active defect centers

- Counted implantation to produce single implanted ions
- Photoluminescence (PL) to confirm color center is optically active
- Hanbury-Brown-Twiss (HBT) measurement confirms a single photon source through $g^{(2)}(t)$



SiV, GeV in Diamond

- Only 3% of implanted ions generate optically active defect center
- To detect photoluminescence, need high-temperature anneal after implant

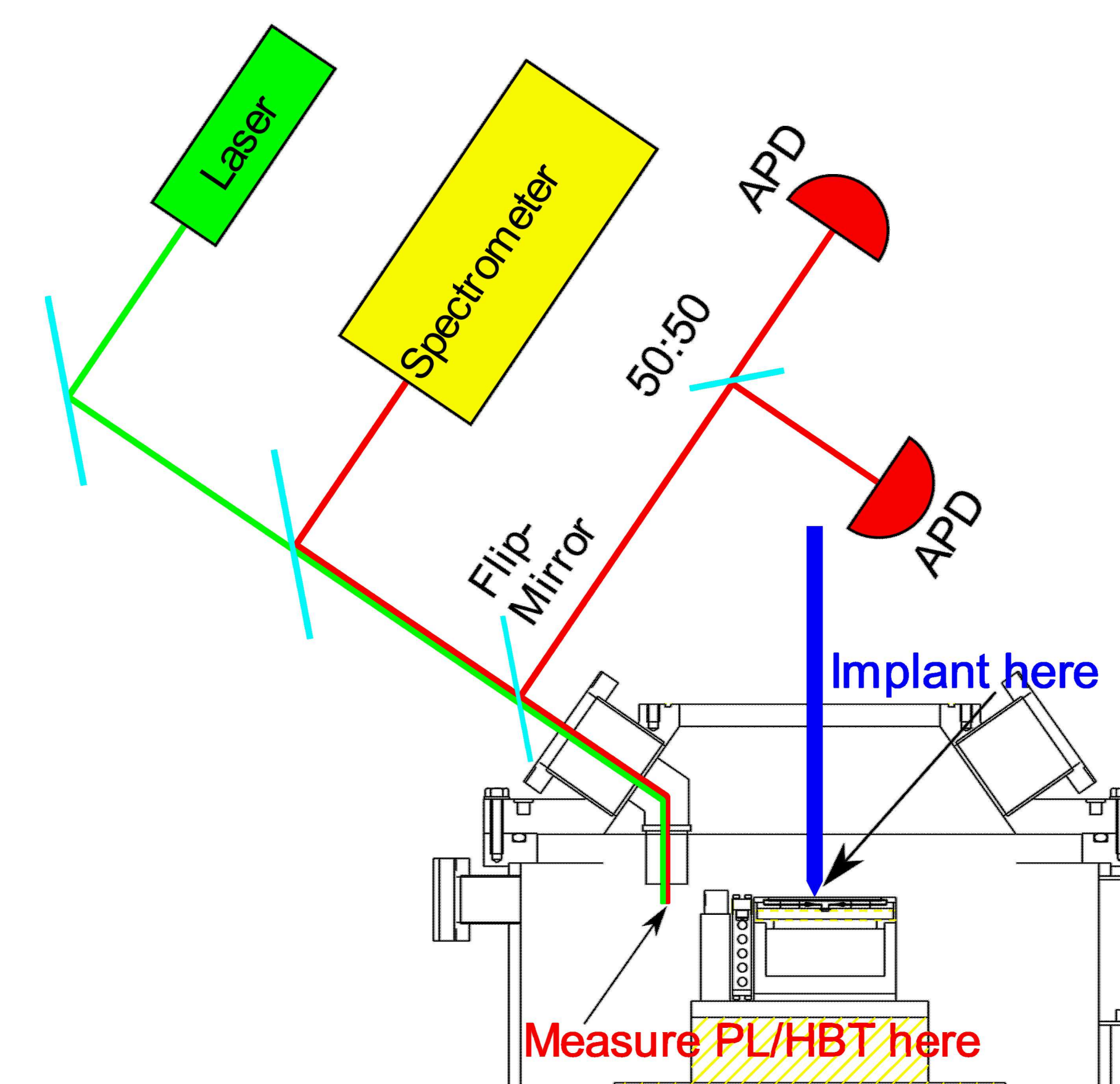
V_{Si} in SiC

- $\geq 5\%$ yield
- No annealing necessary to see photoluminescence

Start with SiC
Then try diamond

Already know how to do counted implants, add in optical measurement

Design of the In-situ Optical Setup



Component	Efficiency (%)
SiC Yield	5
50:50 BS (HBT measmt.)	45
NA (Collection)	35
Objective (Transmission)	80

Estimated Efficiency 10 % Expect 10^4 cps with 1mW pump

Need new sample holder with focus adjust

